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Maximum Power Dissipation Rating:
1.0 watts
Operating Tempurature Range:
-55.0/+125.0 degrees celsius
Storage Tempurature Range:
-65.0/+150.0 degrees celsius
End Application:
Hac/rmpe reac e/i fscm 11293
Features Provided:
Radiation hardened and electrostatic sensitive
Inclosure Material:
Ceramic
Inclosure Configuration:
Leaded chip carrier
Output Logic Form:
Complementary-metal oxide-semiconductor logic
Criticality Code Justification:
Feat
Case Outline Source And Designator:
C-11 mil-m-38510
Terminal Surface Treatment:
Solder
Product Name:
Microcircuit, sram, 32k x (cy7c197)
Voltage Rating And Type Per Characteristic:
-0.5 volts input and 6.0 volts input
Time Rating Per Chacteristic:
55.00 nanoseconds access
Memory Device Type:
Ram
Hybrid Technology Type:
Monolithic
Memory Capacity:
128kx8
Special Features:
Cbbl
Nuclear Hardness Critical Feature:
Hardened

Test Data Document:

81349-mil-m-38510 specification (includes engineering type bulletins, brochures, etc., that reflect specification type data in specification format; excludes commercial catalogs, industry directories, and similar trade publications, reflecting general type data on certain environmental and performance requirements and test conditions that are shown as "typical", "average", "", etc.). And 96906-mil-std-883 standard (includes industry or association standards, individual manufactureer standards, etc.). And 11293-00-1326100 drawing (this is the basic governing drawing, such as a contractor drawing, original equipment manufacturer drawing, etc.; excludes any specification,

standard or other document that may be referenced in a basic governing drawing)

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	Spec	cific	ation	Data
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67268-5962-8866203ua government standard

Purchase Description Identification:

11293-15-1326285-1

Departure From Cited Designator:

Modified for nuclear hardness impact

Shelf Life:

N/a

Unit Of Measure:

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Demilitarization:

Yes - demil/mli

Fiig:

A458a0